

**Notice of References Cited**

Application/Control No.

09/824,512

Applicant(s)/Patent Under  
Reexamination  
PERRY, JOHN S.

Examiner

Cameron Saadat

Art Unit

3713

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,208,955 B1	03-2001	Provan et al.	703/20
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Wingfield, S.L.; Venema, T.L.; □ □ Aerospace and Electronics Conference, 1994. NAECON 1994., Proceedings of the IEEE 1994 National , 23-27 May 1994 □ □ Page(s): 1200 -1207 vol.2
	V	Allred, L.G.; □ □ Aerospace and Electronics Conference, 1990. NAECON 1990., Proceedings of the IEEE 1990 National , 21-25 May 1990 □ □ Page(s): 359 -361 vol.1
	W	Gaston, G.J.; □ □ Advanced MOS and Bi-Polar Devices. IEE Colloquium on , 14 Feb 1995 □ □ Page(s): 17/1 -17/6
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.